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#### STFI20NK50Z

# N-channel 500 V, 0.23 Ω 17 A Zener-protected SuperMESH<sup>TM</sup> Power MOSFET in I<sup>2</sup>PAKFP package

Datasheet — production data

#### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> I <sub>D</sub>		P <sub>TOT</sub>
STFI20NK50Z	500 V	< 0.27 Ω	17 A	40 W

- Fully insulated and low profile package with increased creepage path from pin to heatsink plate
- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized

#### **Applications**

■ Switching applications

#### **Description**

This device is an N-channel Zener-protected Power MOSFET developed using STMicroelectronics' SuperMESH™ technology, achieved through optimization of ST's well-established strip-based PowerMESH™ layout. In addition to a significant reduction in onresistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

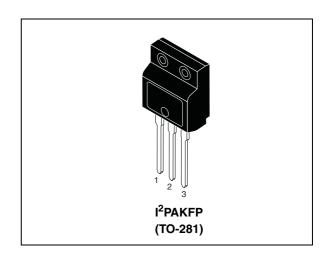


Figure 1. Internal schematic diagram

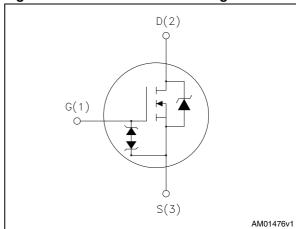


Table 1. Device summary

Order codes	Marking	Package	Packaging
STFI20NK50Z	20NK50Z	I <sup>2</sup> PAKFP (TO-281)	Tube

Contents STFI20NK50Z

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STFI20NK50Z Electrical ratings

## 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	500	V
V <sub>GS</sub>	Gate-source voltage	± 30	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	17 <sup>(1)</sup>	Α
I <sub>D</sub>	I <sub>D</sub> Drain current (continuous) at T <sub>C</sub> = 100 °C		Α
I <sub>DM</sub> <sup>(2)</sup> Drain current (pulsed)		68	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	40	W
ESD	ESD Gate-source human body model (R=1,5 kΩ C=100 pF)		kV
$V_{\rm ISO}$ Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; $T_{\rm C}$ = 25 °C)		2500	V
dv/dt <sup>(3)</sup> Peak diode recovery voltage slope		4.5	V/ns
T <sub>stg</sub>	T <sub>stg</sub> Storage temperature		°C
Tj	Max operating junction temperature	150	°C

<sup>1.</sup> Limited by maximum junction temperature.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	3.1	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub> (1)	Repetitive or non repetitive avalanche current	17	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>J</sub> =25 °C, I <sub>D</sub> =I <sub>AR</sub> , V <sub>DD</sub> =50 V)	850	mJ

<sup>1.</sup> Limited by maximum junction temperature.

<sup>2.</sup> Pulse width limited by safe operating area.

<sup>3.</sup>  $I_{SD}$  < 17 A, di/dt < 200 A/ $\mu$ s,  $V_{DD}$  =80%  $V_{(BR)DSS}$ 

Electrical characteristics STFI20NK50Z

## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage (V <sub>GS</sub> = 0)	I <sub>D</sub> =1 mA	500			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 500 V V <sub>DS</sub> = 500 V, T <sub>C</sub> = 125 °C			1 50	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			± 10	μА
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}$		0.23	0.27	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	$V_{DS} = 15 \text{ V}, I_D = 8.5 \text{ A}$	-	13		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, } f = 1 \text{ MHz,}$ $V_{GS} = 0$	-	2600 328 72		pF pF pF
C <sub>oss eq.</sub> (2)	Equivalent output capacitance	V <sub>DS</sub> =0, V <sub>DS</sub> = 0 to 640 V	-	187		pF
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 250 \text{ V}, I_D = 8.5 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 15</i> )	-	28 20 70 15		ns ns ns ns
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 400 \text{ V}, I_D = 17 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see Figure 16)	-	85 15.5 42	119	nC nC nC

<sup>1.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

<sup>2.</sup>  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current Source-drain current (pulsed)		-		17 68	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 17 A, V <sub>GS</sub> = 0	-		1.6	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}$ = 17 A, di/dt = 100 A/µs $V_{R}$ = 100 V (see <i>Figure 17</i> )	-	355 3.90 22		ns μC Α
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}$ = 17 A, di/dt = 100 A/µs $V_{R}$ = 100 V, Tj = 150 °C (see <i>Figure 17</i> )	-	440 5.72 26		ns μC Α

- 1. Pulsed: pulse duration=300µs, duty cycle 1.5%
- 2. Pulse width limited by safe operating area.

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage $(I_D = 0)$	I <sub>GS</sub> = ± 1mA	30		-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

Electrical characteristics STFI20NK50Z

#### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

10<sup>1</sup> s 100μs 100

Figure 3. Thermal impedance

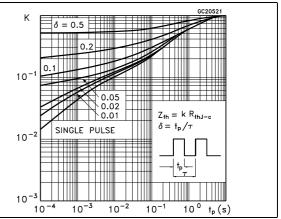


Figure 4. Output characteristics

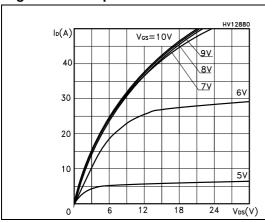


Figure 5. Transfer characteristics

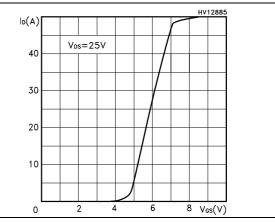


Figure 6. Transconductance

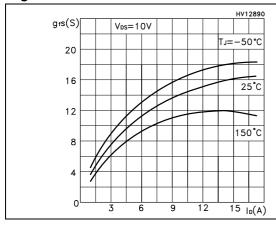
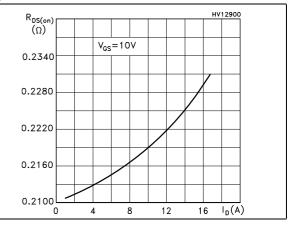


Figure 7. Static drain-source on resistance



3

20

 $V_{GS}(V)$ C(pF) f=1MHz Vgs=0V V<sub>DS</sub>=400V 12 4000 I<sub>D</sub>=17A 9 3000 Ciss 2000 6

Figure 8. Gate charge vs gate-source voltage Figure 9. **Capacitance variations** 

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature

60

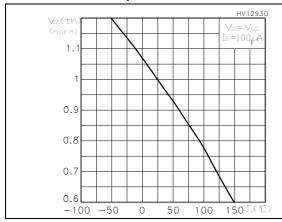
80

100 Qg(nC)

40

1000 20 10 30 0 40 V<sub>DS</sub>(V)

temperature



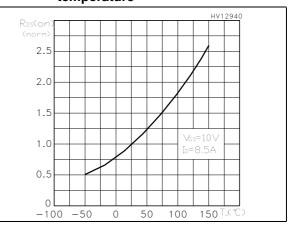
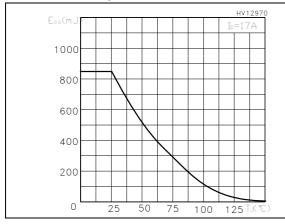
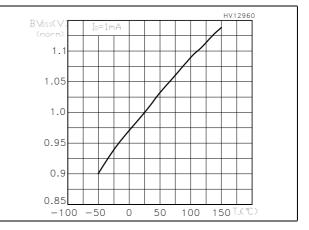


Figure 12. Maximum avalanche energy vs temperature

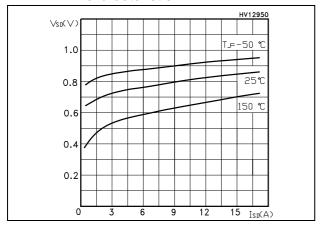
Figure 13. Normalized B<sub>VDSS</sub> vs temperature





Electrical characteristics STFI20NK50Z

Figure 14. Source-drain diode forward characteristic



STFI20NK50Z Test circuits

## 3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

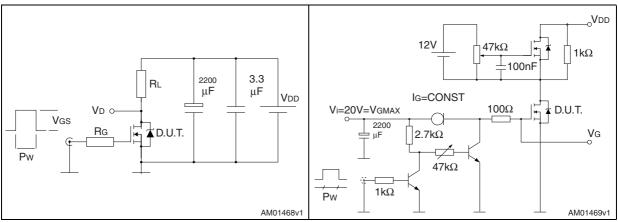


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

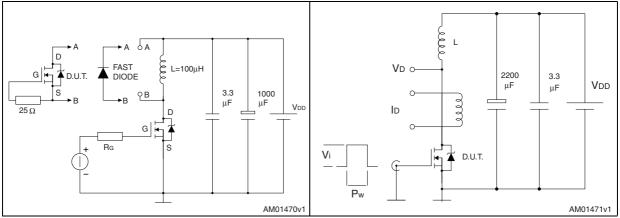
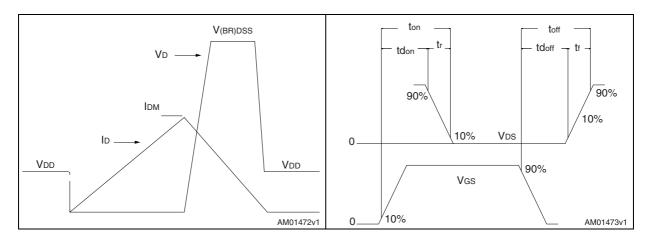


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



# 4 Package mechanical data

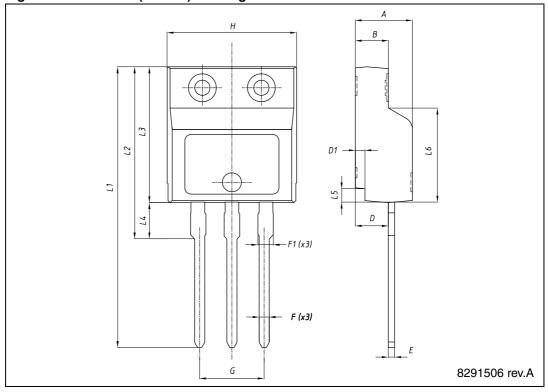
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Table 9. I<sup>2</sup>PAKFP (TO-281) mechanical data

Dim.		mm	
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
В	2.50		2.70
D	2.50		2.75
D1	0.65		0.85
E	0.45		0.70
F	0.75		1.00
F1			1.20
G	4.95	-	5.20
Н	10.00		10.40
L1	21.00		23.00
L2	13.20		14.10
L3	10.55		10.85
L4	2.70		3.20
L5	0.85		1.25
L6	7.30		7.50

Figure 21. I<sup>2</sup>PAKFP (TO-281) drawing



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Revision history STFI20NK50Z

# 5 Revision history

Table 10. Document revision history

Date	Revision	Changes
01-Jul-2011	1	First release.
11-Nov-2011	2	Figure 2: Safe operating area and Figure 3: Thermal impedance have been added.
20-Mar-2012	3	Document status promoted from preliminary data to production data.  The package name has been updated.

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